SHARP GP2TD03/GP2TD04

GP2TD03/GP2TD04

# Tilt Sensor for Optical Disk

# **■** Features

- 1. With built-in lens
- 2. Compact
- Linear output current can be obtained in conformance with tilt angle.

# ■ Applications

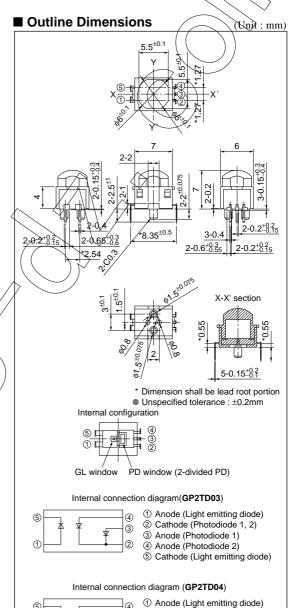
- 1. LD players
- 2. DVD players

■ Absolute Maximum Ratings (Ta=25°C)							
	Parameter	Symbol	Rating	Unit			
Input	Forward current	IF	50	mA			
	Reverse voltage	$V_R$	6	V			
	Power dissipation	$P_{D(IN)}$	75	mW			
Output	Reverse voltage	$V_R$	20	V			
Output	Power dissipation	P <sub>D(OUT)</sub>	75	mW			
Operat	ing temperature	Topr	-10 to +70	°C			
Storag	e temperature	perature $T_{stg}$ $-40 \text{ to } +85$ °C		°C			
*1 Solder	ring temperature	Teol	260	°C /			

Storage temperature  $T_{stg}$  -40 to +85 °C

\*1 Soldering temperature  $T_{sol}$  260 °C

\*1 For 5s below the tie bar cut part (0.45mm from the face A).



② Anode (Common)
③ Cathode (Photodiode 1)
④ Cathode (Photodiode 2)
⑤ Cathode (Light emitting diode)

Notice In the absence of confirmation by device specification sheets, SHARP takes no responsibility for any defects that may occur in equipment using any SHARP devices shown in catalogs, data books, etc. Contact SHARP in order to obtain the latest device specification sheets before using any SHARP device.

Internet address for Electronic Components Group http://www.sharp.co.jp/ecg/

0.45mm

Soldering area

# **■** Electro-optical Characteristics

(Ta=25°C)

	•							1 u 25 C)
Parameter			Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Input (Emitter)	Forward voltage		VF	I <sub>F</sub> =17mA	-	1.25	1.5	V
	Reverse current		IR	V <sub>R</sub> =6V	ı	_	(10)	μA
	Peak sensitivity wavelength		$\lambda p_1$	_	ı	950	1	nm
	Spectrum radiation bandwidth		Δλ	_	-	45	1	nm
Output (Detector)	*2Dark current (Each PD)		Id	V <sub>R</sub> =10V	-		100	nA nA
	Peak sensitivity wavelength	GP2TD03	$\lambda p_2$	_	ı	960	)-)	nm
		GP2TD04	$\lambda p_2$	_	1	900	<i></i>	nm
	Response time	GP2TD03	tr, tf	*2 $V_R=1V$ , $R_L=1k\Omega$	<i>f</i> ~	) 5 <u>0</u> _	_	ns
		GP2TD04	tr, tf	*2 $V_R=1V$ , $R_L=1k\Omega$	[-(	300	_	ns
	Short circuit current	GP2TD03	Isc	*3 Ev=1 000 1x	/-/	4,2/	_	μΑ
		GP2TD04	Isc	*3 Ev=1 000 1x	1	3.5	_	μΑ
Coupling characteristics	*4Difference output increment rate	GP2TD03	A/deg.	$^{*4}$ Vcc=5V, H=10.0mm, $\theta$ y=-0.5 to 0 to +0.5deg.	3.3	6.6	12.87	μA/deg.
		GP2TD04	A/deg.	*4 Vcc=5V, H=10.0mm, θy=-0.5 to 0 to +0.5deg.	3	6	11.7	μA/deg.
	*5 Angle range of tilt angle output 0		θο	*5 Vcc=5V, H=10mm	<i>⟨</i> →²	_	+2	deg.
	*6Monotonous increase range of tilt angle output		<del>0</del> r	*6 Vcc=5V, H=10mm	> 1.5	-	-	deg.
	*7 Non-invert range of tilt angle output		l Ot l	*7 Vcc=5V_H=10mm	5.0	-	-	deg.
	*8Leak		ALEAK	*8 Vcc=5V	ı	_	57	nA

<sup>\*2</sup> Measuring method of response time, refer to Fig.1

Difference output increment rate (A/deg.) shall be the current increase rate of A for I/deg. [{ISC (PD1)-ISC (PD2)} at (+0.5deg.)] + [{ISC (PD2)-ISC (PD1)} at (-0.5deg./)]

Fig.1 Test Circuit for Response Time

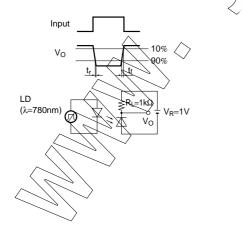
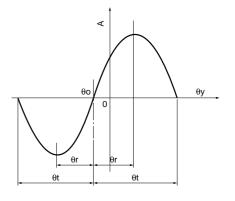


Fig.2 Subtraction Output



<sup>\*3</sup> EV : Illuminance by CIE standard light source A (tungsten lamp).

<sup>\*4</sup> Difference output A stands for A=ISC (PD1)-ISC (PD2).

<sup>\*5</sup> The subtraction output zero angle region shall be the range of the angle at which A is zero.

<sup>\*6</sup> The angle, θr, which monotonously increases when the angle at which A is zero is assumed to be zero.

<sup>\*7</sup> The subtraction output non-reversing region shall be the angle, θt, when the angle which A is zero is assumed to be zero.

<sup>\*8</sup> ALEAK applies to the value of A measured without reflective object.

<sup>\*9</sup> The measurement of \*4 to \*8 shall be or test circuit in accordance with Fig.8 and Fig.9.
\*10 Reflective objected used in test for coupling characteristics shall be multi-layer coating mirror (NIPPON SHINKU KOGAKU made mirror of reflectance of 95% min. at 950nm). The test circuit and the coordinate system shall be as shown in Fig. 8 and Fig. 9. It shall be assumed that there is no deviation in the directions X and Y.

GP2TD03/GP2TD04

Fig.3 Forward Current vs. Ambient Temperature

SHARP

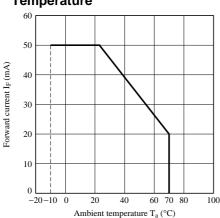


Fig.5 Difference Output vs. Angle (Y-Y' direction)

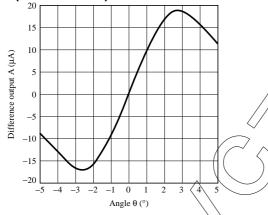


Fig.7 Short-circuit Current vs. Ambient Temperature

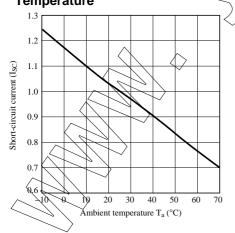


Fig.4 Output Power Dissipation vs. Ambient

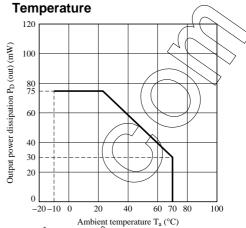
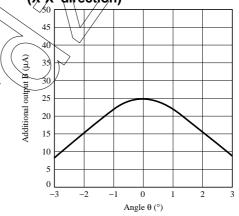


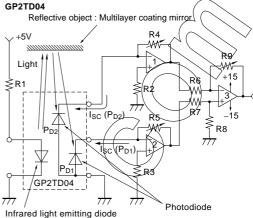
Fig.6 Additional Output vs. Angle (X-X' direction)



SHARP GP2TD03/GP2TD04

# Fig.8 Example of Test Circuit

# GP2TD03 Reflective object : Multilayer coating mirror +5V R9 Light R6 ŠR1 R7 I<sub>SC</sub> (P<sub>D2</sub>) -15 R5 R8 I<sub>SC</sub> (P<sub>D1</sub>) ≶R3 GP2TD03 Photodiode Infrared light emitting diode



 $\text{R1}:220\Omega$ 

R2, R3, R6, R7, R8 :  $10k\Omega$ R4, R5 :  $220k\Omega$  to  $10M\Omega$  (optional)

R9 :  $10k\Omega$  to  $100k\Omega$  (optional) OPAMP : 1, 2, 3

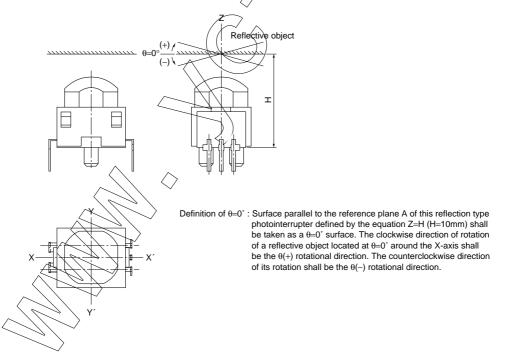
Arrows indicate current directions

Above sample circuits are the model circuit, which amplitude and calculate the signals.

Output is determined by the constant of resistance.

Specifications above are calculated using output current.

# Fig.9 Coordinate System



### ■ Precautions for Use

#### 1. Cleaning

Polycarbonate resin is used as the material of the lens surface. As to cleaning, this reflective type photointerrupter shall not be cleaned by cleaning materials absolutely. Dust and stain shall be cleaned by air blow, or shall be cleaned by soft cloth soaked in washing materials.

2. Reduction of light emitting diode output
In circuit designing, make allowance for the degradation of the light emitting diode output that results from long continuous operation. (50% degradation / 5years)

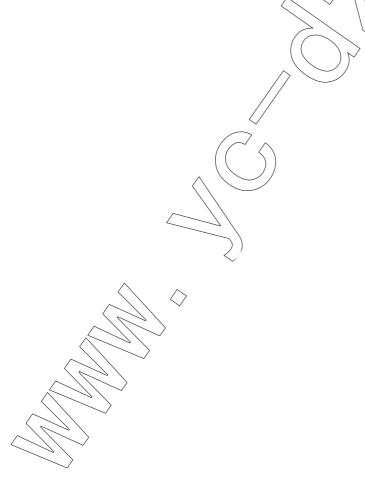
### 3. Soldering

To solder onto lead pins, solder at the position of 0.45mm or more from the package's bottom at 260°C for 2s or less. Please don't bend lead pins from the root of package when soldering. And please take care not to let any external force exert on lead pins. Please don't do soldering with preheating, and please don't do soldering by reflow.

### 4. Positioning pin

This reflection type photointerrupter is positioned in the directions X and Y of the coordinate system shown in Fig.9 by means of two  $\phi$ 1.5mm pins of 2-mm height.

Do not heat stake the positioning pin because it affects the reliability of the internal element adversely. To fix the pin, use adhesives unlikely to erode this reflection type photointerrupter such as epoxy and silicone type adhesives.



### **NOTICE**

- •The circuit application examples in this publication are provided to explain representative applications of SHARP devices and are not intended to guarantee any circuit design or license any intellectual property rights. SHARP takes no responsibility for any problems related to any intellectual property right of a third party resulting from the use of SHARP's devices.
- •Contact SHARP in order to obtain the latest device specification sheets before using any SHARP device. SHARP reserves the right to make changes in the specifications, characteristics, data, materials, structure, and other contents described herein at any time without notice in order to improve design or reliability. Manufacturing locations are also subject to change without notice.
- •Observe the following points when using any devices in this publication. SHARP takes no responsibility for damage caused by improper use of the devices which does not meet the conditions and absolute maximum ratings to be used specified in the relevant specification sheet nor meet the following conditions:
  - (i) The devices in this publication are designed for use in general electronic equipment designs such as:
  - Personal computers
  - Office automation equipment
- Telecommunication equipment [terminal]
- Test and measurement equipment
- Industrial control
- Audio visual equipment
- Consumer electronics
- (ii) Measures such as fail-safe function and redundant design should be taken to ensure reliability and safety when SHARP devices are used for or in connection with equipment that requires higher reliability such as:
- Transportation control and safety equipment (i.e., aircraft, trains, automobiles, etc.)
- Traffic signals
- Gas leakage sensor breakers
- Alarm equipment
- Various safety devices, etc.
- (iii) SHARP devices shall not be used for or in connection with equipment that requires an extremely high level of reliability and safety such as:
- Space applications
- Telecommunication equipment [trunk lines]
- Nuclear power control equipment
- Medical and other life support equipment (e.g., scuba).
- •Contact a SHARP representative in advance when intending to use SHARP devices for any "specific" applications other than those recommended by SHARP or when it is unclear which category mentioned above controls the intended use.
- •If the SHARP devices listed in this publication fall within the scope of strategic products described in the Foreign Exchange and Foreign Trade Control Law of Japan, it is necessary to obtain approval to export such SHARP devices.
- •This publication is the proprietary product of SHARP and is copyrighted, with all rights reserved. Under the copyright laws, no part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, for any purpose, in whole or in part, without the express written permission of SHARP. Express written permission is also required before any use of this publication may be made by a third party.
- Contact and consult with a SHARP representative if there are any questions about the contents of this publication.

